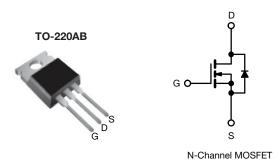


Power MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	60			
R _{DS(on)} (Ω)	$V_{GS} = 5.0 \text{ V}$	0.050		
Q _g (Max.) (nC)	35			
Q _{gs} (nC)	7.1			
Q _{gd} (nC)	25			
Configuration	Single			

FEATURES

- Dynamic dV/dt rating
- · Logic-level gate drive
- R_{DS(on)} specified at V_{GS} = 4 V and 5 V
- 175 °C operating temperature
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRLZ34PbF
Lead (Pb)-free and halogen-free	IRLZ34PbF-BE3

ABSOLUTE MAXIMUM RATINGS (TC	= 25 °C, unl	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V_{DS}	60	- V	
Gate-source voltage			V_{GS}	± 10		
Continuous drain current	V _{GS} at 5 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	- I _D	30		
		T _C = 100 °C		21	Α	
Pulsed drain current ^a			I _{DM}	110		
Linear derating factor				0.59	W/°C	
Single pulse avalanche energy b			E _{AS}	128	mJ	
Maximum power dissipation	T _C =	25 °C	P_{D}	88	W	
Peak diode recovery dV/dt ^c			dV/dt 4.5		V/ns	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +175	°C	
Soldering recommendations (peak temperature) d	For 10 s			300 d	7	
Mounting torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 25 V, Starting T_J = 25 °C, L = 285 μ H, R_g = 25 Ω , I_{AS} = 30 A (see fig. 12)
- c. $I_{SD} \le 30$ A, $dI/dt \le 200$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C
- d. 1.6 mm from case

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e. When mounted on 1" square PCB (FR-4 or G-10 material)



Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	-	62		
Case-to-sink, flat, greased surface	R _{thCS}	0.50	-	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	1.7		

SPECIFICATIONS (T _J = 25 °C, t	ınless otherw	ise noted)						
PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT		
Static								
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference t	Reference to 25 °C, I _D = 1 mA		0.070	-	V/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V$	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	2.0	V	
Gate-source leakage	I _{GSS}	V _G	V _{GS} = ± 10 V		-	± 100	nA	
Zero gate voltage drain current	Inno	V _{DS} = 60 V, V _{GS} = 0 V		-	-	25	uА	
Zero gate voltage drain editerit	I _{DSS}	$V_{DS} = 48 \text{ V}, \text{ V}_{0}$	_{GS} = 0 V, T _J = 150 °C	-	-	250	μΑ	
Drain-source on-state resistance	R _{DS(on)}	$V_{GS} = 5.0 \text{ V}$	I _D = 18 A ^b	-	-	0.050	Ω	
	1 (DS(on)		I _D = 15 A ^b	-	-	0.070		
Forward transconductance	9 _{fs}	V _{DS} = 25 V, I _D = 18 A ^b		12	-	-	S	
Dynamic								
Input capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$			1600	-		
Output capacitance	C _{oss}			-	660	-	pF	
Reverse transfer capacitance	C _{rss}	T = 1.01	MHz, see fig. 5	-	170	-		
Total gate charge	Q_g			-	-	35	nC	
Gate-source charge	Q_{gs}	V _{GS} = 5.0 V	$I_D = 30 \text{ A}, V_{DS} = 48 \text{ V}$ see fig. 6 and 13 ^b	-	-	7.1		
Gate-drain charge	Q _{gd}		2-2	-	-	25		
Turn-on delay time	t _{d(on)}			-	14	-		
Rise time	t _r	V_{DD} = 30 V, I_D = 30 A R_g = 6.0 Ω , R_D = 1.0 Ω , see fig. 10 ^b		-	170	-	- ns	
Turn-off delay time	t _{d(off)}			-	30	-		
Fall time	t _f			-	56	-		
Internal drain inductance	L _D	6 mm (0.25") f	Between lead, 6 mm (0.25") from		4.5	-	- nH	
Internal source inductance	L _S	package and center of die contact		-	7.5	-		
Drain-Source Body Diode Characteristi	cs							
Continuous source-drain diode current	I _S	MOSFET symbo	MOSFET symbol showing the		-	30	- A	
Pulsed diode forward current ^a	I _{SM}	integral reverse p - n junction diode		-	-	110		
Body diode voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 30 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.6	V	
Body diode reverse recovery time	t _{rr}	- T _J = 25 °C, I _F = 30 A, dl/dt = 100 A/μs ^b		_	120	180	ns	
Body diode reverse recovery charge	Q _{rr}			-	0.70	1.3	μC	
Forward turn-on time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_{S} and L_{D})				L _D)		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width $\leq 300~\mu s;~duty~cycle \leq 2~\%$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

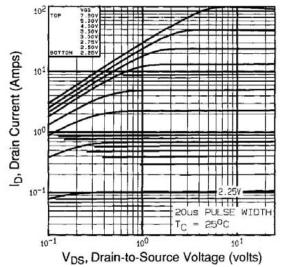


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

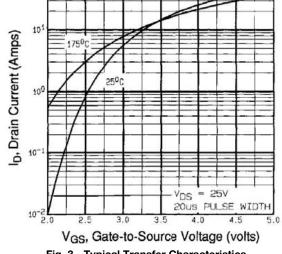


Fig. 3 - Typical Transfer Characteristics

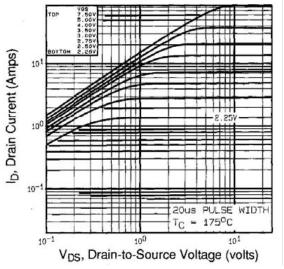


Fig. 2 - Typical Output Characteristics, $T_C = 150 \, ^{\circ}\text{C}$

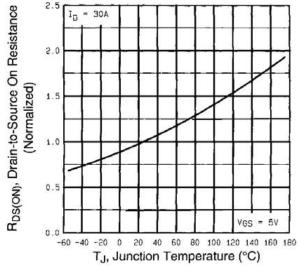


Fig. 4 - Normalized On-Resistance vs. Temperature



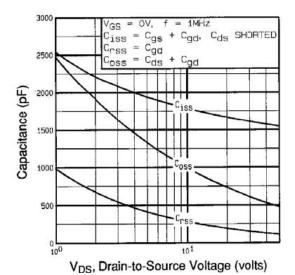


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

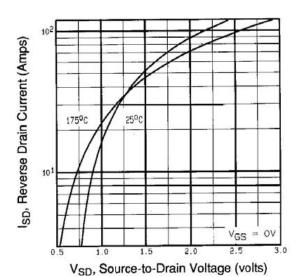


Fig. 7 - Typical Source-Drain Diode Forward Voltage

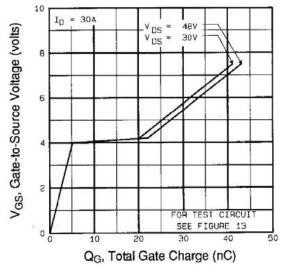


Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage

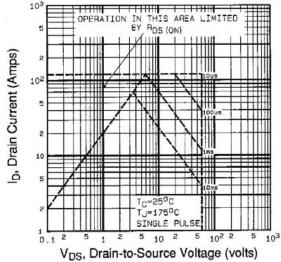


Fig. 8 - Maximum Safe Operating Area



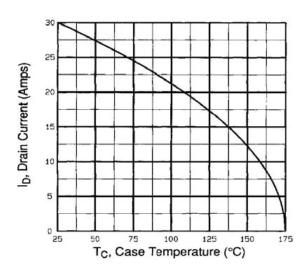


Fig. 9 - Maximum Drain Current vs. Case Temperature

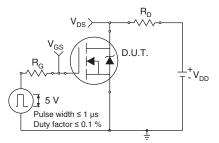


Fig. 10a - Switching Time Test Circuit

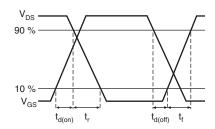


Fig. 10b - Switching Time Waveforms

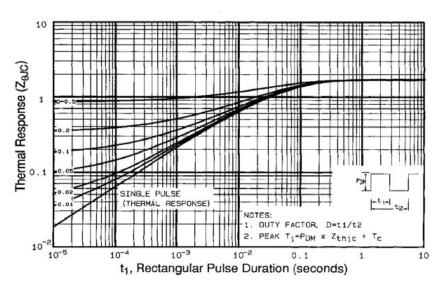


Fig. 10 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



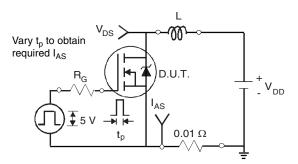


Fig. 12a - Unclamped Inductive Test Circuit

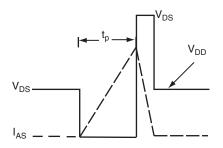


Fig. 12b - Unclamped Inductive Waveforms

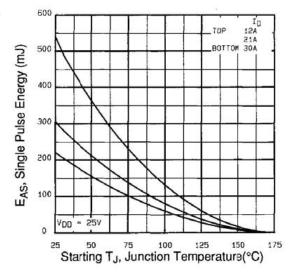


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

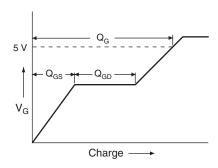


Fig. 13a - Basic Gate Charge Waveform

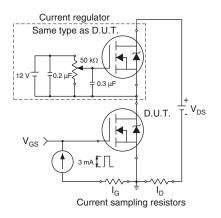
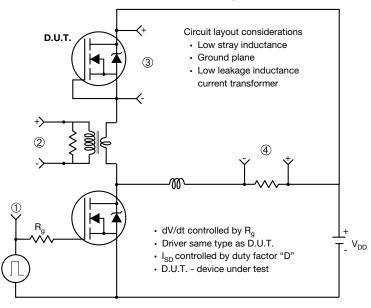


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



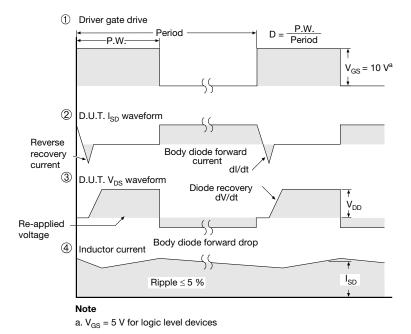


Fig. 14 - For N-Channel

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